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INIE	DARATICE.	DISC	NOTIPE	Filing Date	September 19, 2003	
INFO	ORMATION	DISC	LUSTORE	First Named Inventor	Mark Aaron Behlke	
SIA	TEMENTE	K WH	REMEANI	Group Art Unit	Not assigned	
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Sheet	1	of	1	Attorney Docket Number	PA2003-4	

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/MS/ /MS/	ВС		WO-99/37717		Lee et al.	07-29-1999		<u> </u>
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		OTHER - NON PATENT LITERATURE DOCUMENTS		lation			
Examiner Doc. Initials No.		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number (s), publisher, city and/or country where published.					
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Examiner Signature	/Mark Staples/	Date Considered	01/03/2008

A concise statement of relevance is being submitted in lieu of a translation. 37 CFR 1.98(a)(3).
 An English-language equivalent/patent, or an English-language abstract, or an English-language version of the search report or action by a foreign patent office in a counterpart foreign application indicating the degree of relevance found by the foreign office is being submitted in lieu of a concise explanation of relevance under 37 CFR 1.98(a)(3).

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Application Number	10/666998				
Filing Date	September 19, 2003				
First Named Inventor	Andrei Laikhter				
Group Art Unit	1743				
Examiner Name	Not assigned				
Attorney Docket Number	PA2003-4				

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Examiner Initials	Doc. No.	Application or Patent Number	Kind Code	Name of Patentee or Applicant	Date of Publication	Filing Date If Appropriate
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Examiner Signature	/Mark Staples/	Date Considered	01/03/2008

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⁺ An English-language equivalent/patent, or an English-language abstract, or an English-language version of the search report or action by a foreign patent office in a counterpart foreign application indicating the degree of relevance found by the foreign office is being submitted in lieu of a concise explanation of relevance under 37 CFR 1.98(a)(3).

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Application Number	10/666,998				
Filing Date	9/17/03				
First Named Inventor	Schaadt				
Art Unit	765 1637	L			
Examiner Name	Not Yet Assigned Mark Stap	Les			
Attorney Docket Number	P117-US				

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Examiner	/Mark Staples/	, Date	01/03/2008
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		_		Complete if Known Application Number 10/666,998 Filing Date 9/17/03 First Named Inventor Schaadt Art Unit 1765 1637 Examiner Name NoryerAssisted - Mark Staples Attorney Docket Number P117-US			
INFO	PRMATIO	N DISC	LOSURE	Filing Date	9/17/03		
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Examiner	/Mark Staples/	Date 01/03/2008	
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Co	mplete if Known	
Application Number	10/666,998	
Filing Date	9/17/03	
First Named Inventor	Schaadt	
Art Unit	1765	
Examiner Name	Not Yet Assigned	
Attorney Docket Number	P117-US	

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Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Τ²
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Signature		Considered	

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Complete if Known Substitute for form 1449B/PTO 10/666.998 **Application Number** INFORMATION DISCLOSURE 9/17/03 Filing Date First Named Inventor STATEMENT BY APPLICANT Schaadt 1637 1765 - -**Group Art Unit** Not Yet Assigned Mark Staples Examiner Name (use as many sheets as necessary) of Attorney Docket Number P117-U\$ Sheet

Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	1
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Substitute f	for form 1449B/PTO			Complete if Known		
				Application Number	10/666,998	l
INFOR	RMATION I	JIS	CLOSURE	Filing Date	9/17/03	l
CTAT	EMENT RY	/ Δ	PPLICANT	First Named Inventor	Schaadt	l
SIAII			LICAN	Group Art Unit	4765 1637	l
	(use as many she	ets a	s necessary)	Examiner Name -	-Net Yet Assigned Mark Stapl	e
Sheet	6	of	6	Attorney Docket Number	P117-US	į.

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	Cite No. ¹	item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	י
/MS/	3	SEBEL et al., "Reaction Layer Dynamics in Ion-Assisted Si/XeF2 Etching: Temperature Dependence", J. Vac. Sci. Technol. A, Vac. Surf. Films, Vol. 18, No. 6, (Nov. 2000), pp. 2759-2769 (abstract only).	
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/MS/		SEBEL et al., "Etching of Si Through a Thick Condensed XeF2 Layer", J. Vac. Sci. Technol. A, Vac. Surf. Films, Vol 18, No. 5 (Sept/Oct 2000), pp. 2090-2097 (abstract only).	
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¹ Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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Substitute 101	1011111498/110			Application Number	10/666,998	
INFOR	MATION	DISCL	OSURE	Filing Date	September 19, 2003	
STATI	EMENT B	Y APPL	ICANT	First Named Inventor	Andrei Laikhter	
Diriti				Group Art Unit	1616	
	(use as many she	ets as necessary))	Examiner Name	Badio, Barbara P.	1
Sheet	1 1	of	1	Attorney Docket Number	013670-9004-US00	_

	OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS
Example Initials	The control of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, pages(s), volume-issue numbers(s), publisher, city and/or country where published.
/MSZ	NENBANK Accession No. AF298116
/MS/	GREENE, T.W. and WUTS, P.G.M., Protective Groups in Organic Synthesis, (1999) 3rd edition John Wiley & Sons, Inc., U.S. (BOOK – NOT PROVIDED)
/MS/	HAUGLAND, R.P. et al., Handbook of Fluorescent Probes and Research Chemicals, (1992) 5 th Edition, Molecular Probes, Inc., Oregon, U.S. (BOOK – NOT PROVIDED)
/MS/	MARSHALL, P.N., "Rules for the visible absorption spectra of halogenated fluorescein dyes," Histochemical Journal (1975) 7(1):299-303
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Examiner		Date	01/03/2008
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INFOR	MATION	DISCL	OSURE	Filing Date	September 19, 2003	
STATE	EMENT B	Y APPL	ICANT	First Named Inventor	Andrei Laikhter	
01.111				Group Art Unit	1616	
,	(use as many she	ets as necessary))	Examiner Name	Badio, Barbara P.	
Sheet	1	of	1	Attorney Docket Number	013670-9004-US00	

	U.S. I	PATENT DOCUMENTS	
Examiner Initials	U.S. Patent Document Number	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document
/M8/0	4,439,356	KHANNA et al.	March 1984
/MS/20	5,188,934	MENCHEN et al.	February 1993
Mer 101	6,531,591	FENSHOLDT, J.	March 2003
/MS/ WY & TI	RADEME	c.	

- 4.4	FOREIGN PATENT DOCUMENTS								
Examiner Initials	Country Code	Foreign Patent Document Number	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document	Translation	English Abstract			
/MS/	EP	0272007	Applied Biosystems	June 1988					
/MS/	wo	91/05060	Applied Biosystems	April 1991					
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Examiner Signature	/Mark Staples/	Date Considered	01/03/2008

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1			First named Inventor	Andrei Laikhter			
			Group Art Unit	1617			
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	Sheet 1 of 1		Attorney Docket Number	013670-9004-US00			
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		U.S. Patent	Documents		_		
Examiner Initials	U.S. Patent Document Number Nam		e of Patentee or Applicant of Cited Document	Date of Publication of Cited Document			
/MS/	3,218,309		Elslager et al.	11/16/1965			
/MS/	2005/0112673		Laikhter et al.	5/26/2005			
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/MS/	DT	2546535	Bayer AG	4/28/1977 Abstr	act Only	, Y			
/MS/	JP	52-88681	Mitsubishi Chemical Industries	7/25/1977 Abst	act Onl	y Y			
/MS/	JР	52-91031	Mitsubishi Chemical Industries	8/1/1977 Abstr	act Only	Y			
/MS/	wo	2004/026804	Integrated DNA Technologies Inc.	4/1/2004					
/MS/	wo	2005/049849	Integrated DNA Technologies Inc.	6/2/2005					

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Examiner Signature	/Mark Staples/	Date Considered	01/03/2008

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				Group Art Unit	1617
	(use as many she	ets as necessary))	Examiner Name	Unknown
Sheet	1	of	1	Attorney Docket Number	013670-9004-00

		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS
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/MS	/	HO, M.S. et al., "Azo polymers for reversible optical storage. 7. The effect of the size of the photochromic groups," Macromolecules (1995) 28(18):6124-6127
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Examiner	/Mark Staples/	Date	01/03/2008	
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Application Number

NFORMATION DISCLOSURE STATEMENT BY APPLICANT		Filing Date		2003-09-19							
		First Na	amed In	ventor	Andre	Andrei Laikhter					
		Art Unit			1637						
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